- **Fully Integrated SONET/SDH Transceiver to Support Clock/Data Recovery and Multiplexer/Demultiplexer Functions**
- **Enhanced Jitter Tolerance Over SLK2701**
- **Supports 2.7 Gbps OC-48 FEC Rate, OC-48, OC-24, OC-12, Gigabit Ethernet, and OC-3 Data Rate With Autorate Detection**
- **Supports Transmit Only, Receiver Only, Transceiver and Repeater Functions in a Single Chip Through Configuration Pins**
- **Supports SONET/SDH Frame Detection**
- **On-Chip PRBS Generation and Verification**
- **Supports 4-Bit LVDS (OIF99.102) Electrical Interface**
- **Single 2.5-V Power Supply**
- **Interfaces to Back Plane, Copper Cables, or Optical Modules**
- **Hot Plug Protection**
- **Low Jitter PECL-Compatible Differential Serial Interface With Programmable De-Emphasis for the Serial Output**
- **On-Chip Termination for LVDS and PECL-Compatible Interface**
- **Receiver Differential Input Thresholds 150 mV Minimum**
- **Supports SONET Loop Timing**
- **Low Power <900 mW at OC-48 Data Rate**
- **ESD Protection >2 kV**
- **622-MHz Reference Clock**
- **Maintains Clock Output in Absence of Data**
- **Local and Remote Loopback**
- **Parity Checking and Generation for the LVDS Interface**
- **100-Pin PZP Package With PowerPad™ Design**

description

The SLK2721 device is a single chip, multirate transceiver that derives high-speed timing signals for SONET/SDH-based equipment. The device performs clock and data recovery, serial-to-parallel/parallel-to-serial conversion, and a frame detection function conforming to the SONET/SDH standards.

The device can be configured to operate under OC-48, OC-24, OC-12, or OC-3 data rate through the rate selection pins or the autorate detection function. An external reference clock operating at 622.08 MHz is required for the recovery loop, and it also provides a stable clock source in the absence of serial data transitions.

The SLK2721 device accepts 4-bit LVDS parallel data/clock and generates a NRZ SONET/SDH-compliant signal at the OC-3, OC-12, OC-24, or OC-48 data rate. It also recovers the data and clock from the serial SONET stream and demultiplexes it into 4-bit LVDS parallel data for full duplex operation. TXDATA0 and RXDATA0 are the first bits that are transmitted and received in time, respectively. The serial interface is a low jitter, PECL-compatible differential interface.

The SLK2721 device supports an FEC data rate up to 2.7 Gbps when configured to operate at the OC-48 data rate and provided with an external reference clock that is properly scaled.

The SLK2721 device provides a comprehensive suite of built-in tests for self-test purposes including local and remote loopback and pseudorandom bit stream (PRBS) (2^7-1) generation and verification.

The device comes in a 100-pin VQFP package that requires a single 2.5-V supply with 3.3-V tolerant inputs on the control pins. The SLK2721 device is very power efficient, dissipating less than 900 mW at 2.488 Gbps, the OC-48 data rate. It is characterised for operation from −40°C to 85°C.

AVAILABLE OPTIONS

T_A	PACKAGE
	PowerPAD QUAD (PZP)
−40°C to 85°C	SLK2721IPZP

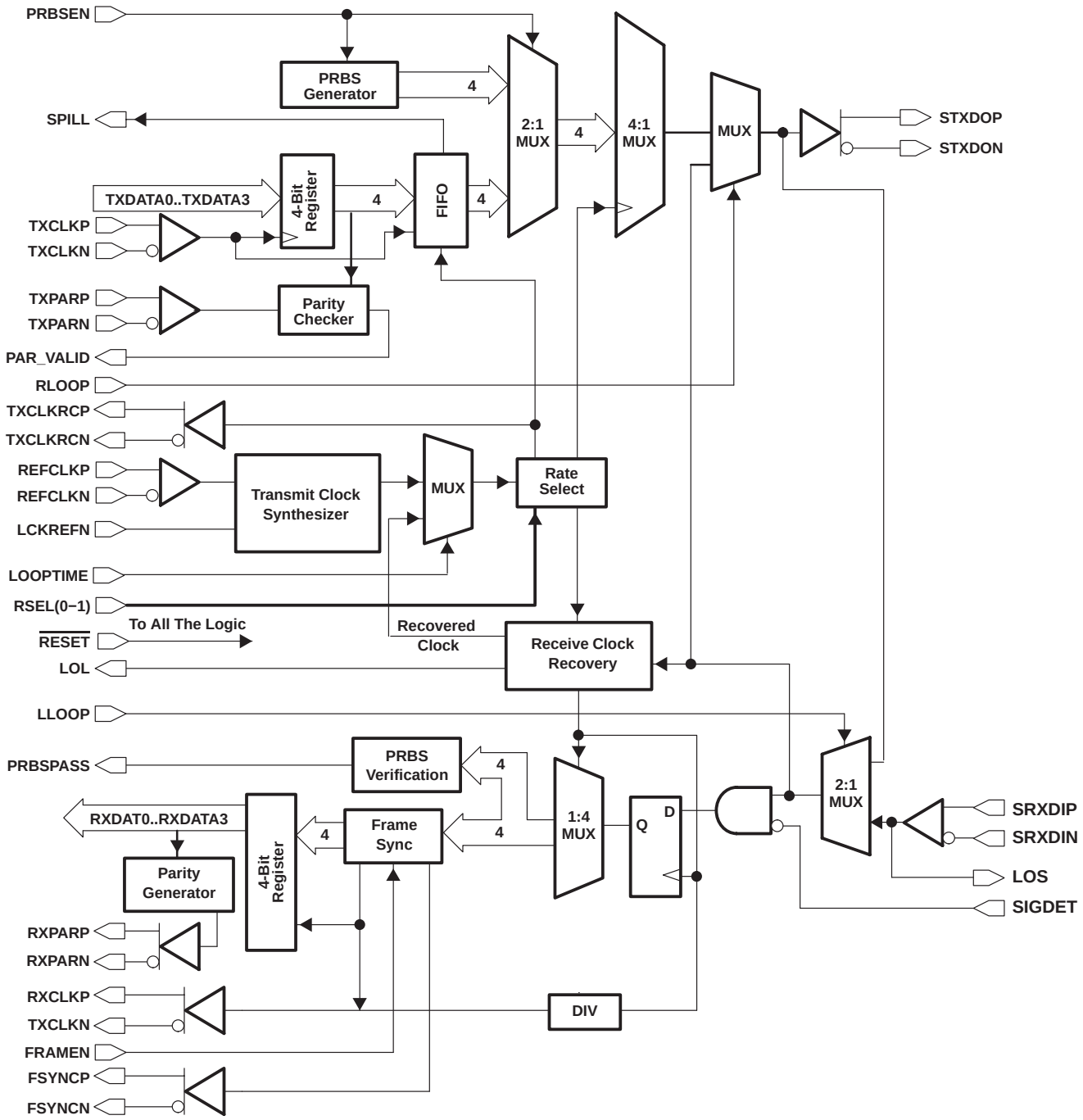
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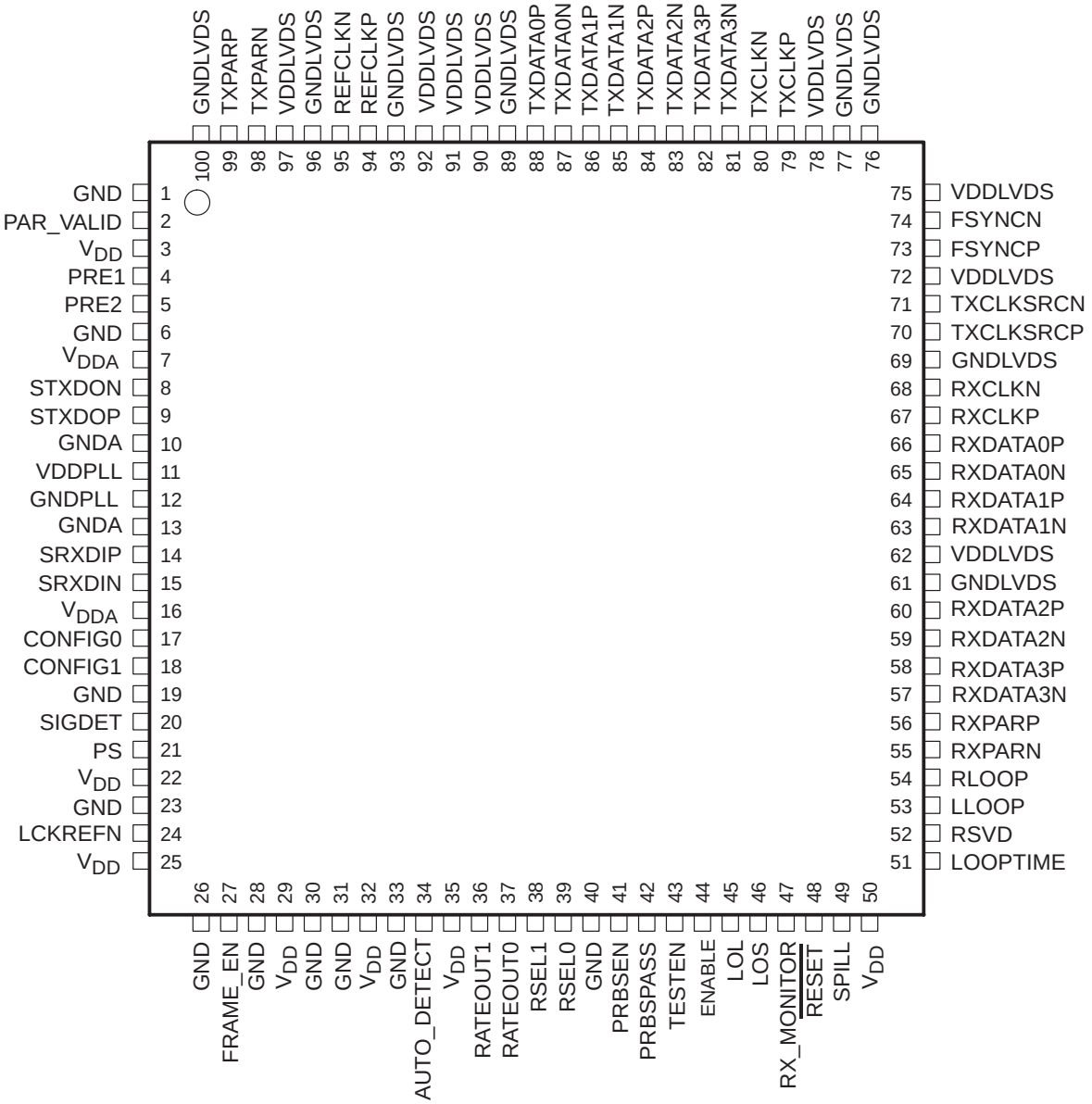
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block diagram



PZP PACKAGE
(TOP VIEW)



Terminal Functions

clock pins

TERMINAL NAME	TERMINAL NO.	TYPE	DESCRIPTION
REFCLKP REFCLKN	94 95	LVDS/PECL compatible input	Differential reference input clock. There is an on-chip 100-Ω termination resistor differentially placed between REFCLKP and REFCLKN. The dc bias is also provided on-chip for the ac-coupled case.
RXCLKP RXCLKN	67 68	LVDS output	Receive data clock. The data on RXDATA(0:3) is on the falling edges of RXCLKP. The interface of RXDATA(0:3) and RXCLKP is source synchronous (refer to Figure 6).
TXCLKP TXCLKN	79 80	LVDS input	Transmit data clock. The data on TXDATA(0:3) is latched on the rising edge of TXCLKP.
TXCLKSRCP TXCLKSRCN	70 71	LVDS output	Transmit clock source. A clock source generated from the SLK2721 device to the downstream device (i.e., framer) that could be used by the downstream device to transmit data back to the SLK2721 device. This clock is frequency-locked to the local reference clock.

serial side data pins

TERMINAL NAME	TERMINAL NO.	TYPE	DESCRIPTION
SRXDIP SRXDIN	14 15	PECL compatible input	Receive differential pairs; high-speed serial inputs
STXDOP STXDON	9 8	PECL compatible output	Transmit differential pairs; high-speed serial outputs

parallel side data pins

TERMINAL NAME	TERMINAL NO.	TYPE	DESCRIPTION
FSYNCP FSYNCN	73 74	LVDS output	Frame sync pulse. This signal indicates the frame boundaries of the incoming data stream. If the frame-detect circuit is enabled, FSYNC pulses for four RXCLKP and RXCLKN clock cycles, when it detects the framing patterns.
RXDATA[0:3] P/N	66−63 60−57	LVDS output	Receive data pins. Parallel data on this bus is valid on the falling edge of RXCLKP (refer to Figure 6). RXDATA0 is the first bit received in time.
RXPARP RXPARN	56 55	LVDS output	Receive data parity output
TXDATA[0:3] P/N	88−81	LVDS input	Transmit data pins. Parallel data on this bus is clocked on the rising edge of TXCLKP. TXDATA0 is the first bit transmitted in time.
TXPARP TXPARN	99 98	LVDS input	Transmit data parity input

Terminal Functions (Continued)

control/status pins

TERMINAL NAME	TERMINAL NO.	TYPE	DESCRIPTION
AUTO_DETECT	34	TTL input (with pulldown)	Data rate autodetect enable. Enable the autodetection function for different data rates.
CONFIG0 CONFIG1	17 18	TTL input (with pulldown)	Configuration pins. Put the device under one of the four operation modes: TX only, RX only, transceiver, or repeater.
ENABLE	44	TTL input (with pullup)	Standby enable. When this pin is held low, the device is disabled for IDDQ testing. When high, the device operates normally.
FRAME_EN	27	TTL input (with pullup)	Frame sync enable. When this pin is asserted high, the frame synchronization circuit for byte alignment is turned on.
LCKREFN	24	TTL input (with pullup)	Lock to reference. When this pin is low, RXCLKP/N output is forced to lock to REFCLK. When high, RXCLKP/N is the divided down clock extracted from the receive serial data.
LLOOP	53	TTL input (with pulldown)	Local loopback enable. When this pin is high, the serial output is internally looped back to its serial input.
LOL	45	TTL output	Loss of lock. When the clock recovery loop has locked to the input data stream and the phase differs by less than 100 ppm from REFCLK, then LOL is high. When the phase of the input data stream differs by more than 100 ppm from REFCLK, then LOL is low. If the difference is too large (> 500 ppm), the LOL output is not valid.
LOOPTIME	51	TTL input (with pulldown)	Loop timing mode. When this pin is high, the PLL for the clock synthesizer is bypassed. The recovered clock timing is used to send the transmit data.
LOS	46	TTL output	Loss of signal. When no transitions appear on the input data stream for more than 2.3 μs, a loss of signal occurs and LOS goes high. The device also transmits all zeroes downstream using REFCLK as its clock source. When a valid SONET signal is received, the LOS signal goes low.
PAR_VALID	2	TTL output	Parity checker output. The internal parity checker on the parallel side of the transmitter checks for even parity. If there is a parity error, the pin is pulsed low for two clock cycles.
PRBSEN	41	TTL input (with pulldown)	PRBS testing enable. When this pin is asserted high, the device is put into the PRBS testing mode.
PRBSPASS	42	TTL output	PRBS test result. This pin reports the status of the PRBS test results (high = pass). When PRBSEN is disabled, the PRBSPASS pin is set low. When PRBSEN is enabled and a valid PRBS is received, then the PRBSPASS pin is set high.
PRE1 PRE2	4 5	TTL input (with pulldown)	Programmable de-emphasis control. Combinations of these two bits can be used to optimize serial data transmission.
PS	21	TTL input (with pulldown)	Polarity select. This pin, used with the SIGDET pin, sets the polarity of SIGSET. When high, SIGDET is an active low signal. When low, SIGDET is an active high signal.
RATEOUT0 RATEOUT1	37 36	TTL output	Autorate detection outputs. When AUTO_DETECT is high, the autodetection circuit generates these two bits to indicate the data rates for the downstream device.
$\overline{\text{RESET}}$	48	TTL input (with pulldown)	TXFIFO and LOL reset pin. Low is reset and high is normal operation.
RLOOP	54	TTL input (with pulldown)	Remote loopback enable. When this pin is high, the serial input is internally looped back to its serial output with the timing extracted from the serial data.
RSEL0 RSEL1	39 38	TTL input (with pulldown)	Data rate configuration pins. Put the device under one of the four data rate operations: OC-48, OC-24, OC-12, or OC-3.
RX_MONITOR	47	TTL input (with pulldown)	RX parallel data monitor in repeater mode. This pin is only used when the device is put under repeater mode. When high, the RX demultiplexer circuit is enabled and the parallel data is presented. When low, the demultiplexer is shut down to save power.
SIGDET	20	TTL input (with pulldown)	Signal detect. This pin is generally connected to the output of an optical receiver. This signal may be active high or active low depending on the optical receiver. The SIGDET input is XORed with the PS pin to select the active state. When SIGDET is in the inactive state, data is processed normally. When activated, indicating a loss of signal event, the transmitter transmits all zeroes and force the LOS signal to go high.

Terminal Functions(Continued)

control/status pins (continued)

TERMINAL NAME	TERMINAL NO.	TYPE	DESCRIPTION
SPILL	49	TTL output	TX FIFO collision output
TESTEN	43	TTL input (with pulldown)	Production test mode enable. This pin must be left unconnected or tied low.

voltage supply and reserved pins

TERMINAL NAME	TERMINAL NO.	TYPE	DESCRIPTION
GND	1, 6, 19, 23, 26, 28, 30, 31, 33, 40	Ground	Digital logic ground
GNDA	10, 13	Ground	Analog ground
GNDLVDS	61, 69, 76, 77, 89, 93, 96, 100	Ground	LVDS ground
GNDPLL	12	Supply	PLL ground
RSVD	52	Reserved	This pin needs to be tied to ground or left floating for normal operation.
V_{DD}	3, 22, 25, 29, 32, 35, 50	Supply	Digital logic supply voltage (2.5 V)
V_{DDA}	7, 16	Supply	Analog voltage supply (2.5 V)
VDDLVDS	62, 72, 75, 78, 90, 91, 92, 97	Supply	LVDS supply voltage (2.5 V)
VDDPLL	11	Supply	PLL voltage supply (2.5 V)

detailed description

The SLK2721 device is designed to support the OC-48/24/12/3 data rates. It also supports a higher data rate that may be required for FEC support, up to 2.7 Gbps. The operating data speed can be configured through the RSEL0 and RSEL1 pins as indicated in Table 1 for normal SONET rates. For FEC support, the clock and data rates need to be scaled up as required. The highest data and clock rates supported are 675 Mbps and 675 MHz, respectively.

Table 1. Data Rate Select

SERIAL DATA RATE	RSEL0	RSEL1	PARALLEL LVDS DATA RATE	TXCLK/RXCLK
OC-48: 2.488 Gbps	0	0	622.08 Mbps	622.08 MHz
OC-24: 1.244 Gbps	1	0	311.04 Mbps	311.04 MHz
OC-12: 622 Mbps	0	1	155.52 Mbps	155.52 MHz
OC-3: 155.52 Mbps	1	1	38.88 Mbps	38.88 MHz

The user can also enable the autorate detection circuitry through the AUTO_DETECT pin. The device automatically detects the OC-N of the data line rate and generates two bits of output to indicate the data rate to other devices in the system. When using AUTO_DETECT, RSEL0 and RSEL1 need to be set to 00 or be unconnected.

Table 2. Data Rate Reporting Under Autorate Detection Mode

SERIAL DATA RATE	RATEOUT0	RATEOUT1	PARALLEL LVDS DATA RATE	TXCLK/RXCLK
OC-48: 2.488 Gbps	0	0	622.08 Mbps	622.08 MHz
OC-24: 1.244 Gbps	1	0	311.04 Mbps	311.04 MHz
OC-12: 622 Mbps	0	1	155.52 Mbps	155.52 MHz
OC-3: 155.52 Mbps	1	1	38.88 Mbps	38.88 MHz

The SLK2721 device has four operational modes controlled by two configuration pins. Table 3 lists these operational modes. When the device is put in a certain mode, unused circuit blocks are powered down to conserve system power.

While the transceiver mode, transmit only mode, and receive only mode are straightforward, the repeater mode of operation is shown in Figure 4. The receive serial data is recovered by the extracted clock, and it is then sent back out on the transmit serial outputs. The data eye is open both vertically and horizontally in this process. In the repeater mode, the user can select to turn on the RX demultiplexer function through RX_MONITOR pin and allow the parallel data to be presented. This feature enables the repeater device not only to *repeat* but also to *listen in*.

Table 3. Operational Modes

MODE	CONFIG0	CONFIG1	DESCRIPTION
1	0	0	Full duplex transceiver mode
2	0	1	Transmit only mode
3	1	0	Receive only mode
4	1	1	Repeater mode

high-speed electrical interface

The high-speed serial I/O uses a PECL-compatible interface. The line could be directly coupled or ac-coupled. Refer to Figures 10 and 11 for configuration details. As shown in the figures, an on-chip 100-Ω termination resistor is placed differentially at the receive end.

detailed description (continued)

The PECL output also provides de-emphasis for compensating ac loss when driving a cable or PCB backplane over long distance. The level of the de-emphasis is programmable via the PRE1 and PRE2 pins. Users can use software to control the strength of the de-emphasis to optimize the device for a specific system requirement.

Table 4. Programmable De-emphasis

PRE1	PRE2	DE-EMPHASIS LEVEL (V_{odp}/V_{odd} † −1)
0	0	De-emphasis disabled
1	0	10%
0	1	20%
1	1	30%

† V_{odp}: Differential voltage swing when there is a transition in the data stream.
V_{odd}: Differential voltage swing when there is no transition in the data stream.

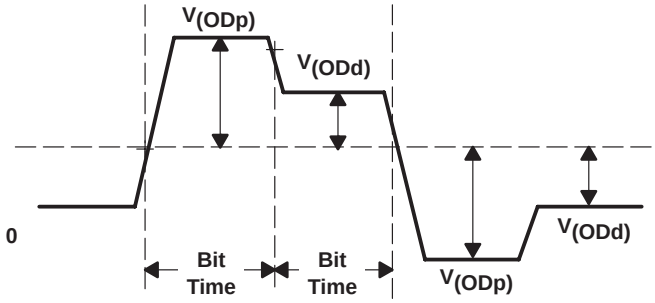


Figure 1. Output Differential Voltage Under De-emphasis

LVDS parallel data interface

The parallel data interface consists of a 4-bit parallel LVDS data and clock. The device conforms to the OIF99.102 specification when operating at the OC-48 rate. When operating at lower serial rates, the clock and data frequency are scaled down accordingly, as indicated in Table 1. The parallel data TXDATA[0:3] is latched on the rising edge of TXCLK and then is sent to a data FIFO to resolve any phase difference between TXCLK and REFCLK. If there is a FIFO overflow condition, the SPILL pin is set high. The FIFO resets itself to realign between two clocks. The internal PLL for the clock synthesizer is locked to the REFCLK, and it is used as the timing to serialize the parallel data (except for the loop timing mode where the recovered clock is used). On the receive side, RXDATA[0:3] is updated on the rising edge of RXCLK. Figures 7 and 8 show the timing diagram for the parallel interface.

The SLK2721 device also has a built-in parity checker and generator for error detection of the LVDS interface. On the transmit side, it accepts the parity bit, TXPARP/N, and performs the parity checking function for even parity. If an error is detected, it pulses the PAR_VALID pin low for two clock cycles. On the receive side, the parity bit, RXPARP/N, is generated for the downstream device for parity error checking.

Differential termination 100-Ω resistors are included on-chip between TXDATAP/N and TXCLKP/N.

reference clock

The device accepts a 622.08-MHz clock. The REFCLK input is compatible with the LVDS level and also the 3.3-V LVPECL level using ac-coupling. A 100-Ω differential termination resistor is included on-chip, as well as a dc-biasing circuit (3 kΩ to VDD and 4.5 kΩ to GND) for the ac-coupled case. A high quality REFCLK must be used on systems required to meet SONET/SDH standards. For non-SONET/SDH-compliant systems, loose tolerances may be used.

detailed description (continued)

clock and data recovery

The CDR unit of the SLK2721 device recovers the clock and data from the incoming data streams.

In the event of receive data loss, the PLL automatically locks to the local REFCLK to maintain frequency stability. If the frequency of the data differs by more that 100 ppm with respect to the REFCLK frequency, the LOL pin is asserted as a warning. Actual loss of lock occurs if the data frequency differs by more than 170 ppm.

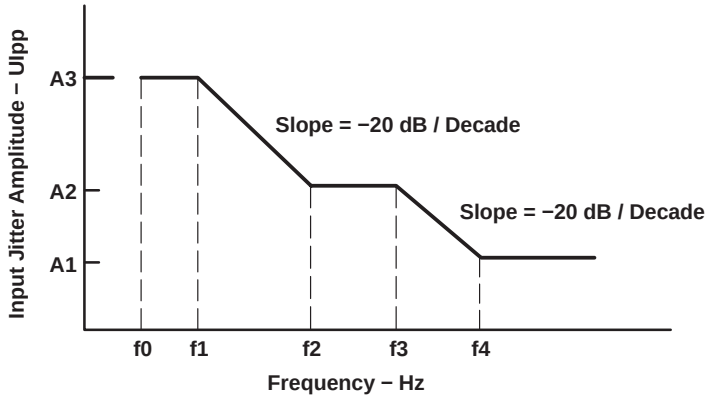
minimum transition density

The loop filter transfer function is optimized to enable the CDR to track ppm difference in the clocking and tolerate the minimum transition density that can be received in a SONET data signal (±20 ppm). The transfer function yields a typical capture time of 3500-bit times for random incoming NRZ data after the device is powered up and achieves frequency locking.

The device tolerates up to 72 consecutive digits (CID) without sustaining an error.

jitter tolerance

Input jitter tolerance is defined as the peak-to-peak amplitude of sinusoidal jitter applied on the input signal that causes the equivalent 1-dB optical/electrical power penalty. This refers to the ability of the device to withstand input jitter without causing a recovered data error. The device has a jitter tolerance that exceeds the mask shown in Figure 2 (GR-253 Figure 5-28). This jitter tolerance is specified using a pseudorandom data pattern of 2^{31} –1.



OC-N/STS-N LEVEL	f0 (Hz)	F1 (Hz)	F2 (Hz)	F3 (kHz)	F4 (kHz)	A1 (UIpp)	A2 (UIpp)	A3 (UIpp)
3	10	30	300	6.5	65	0.15	1.5	15
12	10	30	300	25	250	0.15	1.5	15
24	Not specified							
48	10	600	6000	100	1000	0.15	1.5	15

Figure 2. Input Jitter Tolerance

jitter generation

The jitter of a serial clock and serial data outputs must not exceed 0.01 UI_{rms}/0.1 UI_{p-p} when a serial data with no jitter is presented to the inputs. The measurement bandwidth for intrinsic jitter is 12 kHz to 20 MHz.

loop timing mode

When LOOPTIME is high, the clock synthesizer used to serialize the transmit data is bypassed and the timing is provided by the recovered clock. However, REFCLK is still needed for the recovery loop operation.

detailed description (continued)

loss-of-lock indicator

The SLK2721 device has a lock detection circuit to monitor the integrity of the data input. When the clock recovery loop is locked to the input serial data stream, the LOL signal goes high. If the recovered clock frequency deviates from the reference clock frequency by more than 100 ppm, LOL goes low. If the data stream clock rate deviates by more than 170 ppm, loss of lock occurs. If the data streams clock rate deviates more than 500 ppm from the local reference clock, the LOL output status might be unstable. Upon power up, the LOL goes low until the PLL is close to phase lock with the local reference clock.

loss of signal

The loss-of-signal (LOS) alarm is set high when no transitions appear in the input data path for more than 2.3 μs. The LOS signal becomes active when the above condition occurs. If the serial inputs of the device are ac-coupled to its source, the ac-coupling capacitor needs to be big enough to maintain a signal level above the threshold of the receiver for the 2.3-μs no transition period. Once activated, the LOS alarm pin is latched high until the receiver detects an A1A2 pattern. The recovered clock (RXCLK) is automatically locked to the local reference when LOS occurs. The parallel data (RXDATAx) may still be processed even when LOS is activated.

signal detect

The SLK2721 device has an input SIGDET pin to force the device into the loss-of-signal state. This pin is generally connected to the signal detect output of the optical receiver. Depending on the optics manufacturer, this signal can be either active high or active low. To accommodate the differences, a polarity select (PS) is used. For an active low, SIGDET input sets the PS pin high. For an active high, SIGDET input sets the PS pin low. When the PS signal pin and SIGDET are of opposite polarities, the loss-of-signal state is generated and the device transmits all zeroes downstream.

multiplexer operation

The 4-bit parallel LVDS data is clocked into an input buffer by a clock derived from the synthesized clock. The data is then clocked into a 4:1 multiplexer. The D0 bit is the most significant bit and is shifted out first in the serial output stream.

demultiplexer operation

The serial 2.5-Gbps data is clocked into a 1:4 demultiplexer by the recovered clock. The D0 bit is the first bit that is received in time from the input serial stream. The 4-bit parallel data is then sent to the LVDS driver along with the divided down recovered clock.

frame synchronization

The SLK2721 device has a SONET/SDH-compatible frame detection circuit that can be enabled or disabled by the user. Frame detection is enabled when the FRAME_EN pin is high. When enabled, it detects the A1, A2 framing pattern, which is used to locate and align the byte and frame boundaries of the incoming data stream. When FRAME_EN is low, the frame detection circuitry is disabled and the byte boundary is frozen to the location found when detection was previously enabled.

The frame detect circuit searches the incoming data for three consecutive A1 bytes followed immediately by one A2 byte. The data alignment circuit then aligns the parallel output data to the byte and frame boundaries of the incoming data stream. During the framing process the parallel data bus will not contain valid and aligned data. Upon detecting the third A1, A2 framing patterns that are separated by 125 μs from each other, the FSYNC signal goes high for four RXCLK cycles, indicating frame synchronization has been achieved.

The probability that random data in a SONET/SDH data stream will mimic the framing pattern in the data payload is extremely low. However, there is a state machine built in to prevent false reframing if a framing pattern does show up in the data payload.

detailed description (continued)

testability

The SLK2721 device has a comprehensive suite of built-in self-tests. The loopback function provides for at-speed testing of the transmit/receive portions of the circuitry. The ENABLE pin allows for all circuitry to be disabled so that an IDDQ test can be performed. The PRBS function allows for a built-in self-test (BIST).

IDDQ function

When held low, the ENABLE pin disables all quiescent power in both the analog and digital circuitry. This allows for IDDQ testing on all power supplies and can also be used to conserve power when the link is inactive.

local loopback

The LLOOP signal pin controls the local loopback. When LLOOP is high, the loopback mode is activated and the parallel transmit data is selected and presented on the parallel receive data output pins. The parallel transmit data is also multiplexed and presented on the high-speed serial transmit pins. Local loopback can only be enabled under transceiver mode.

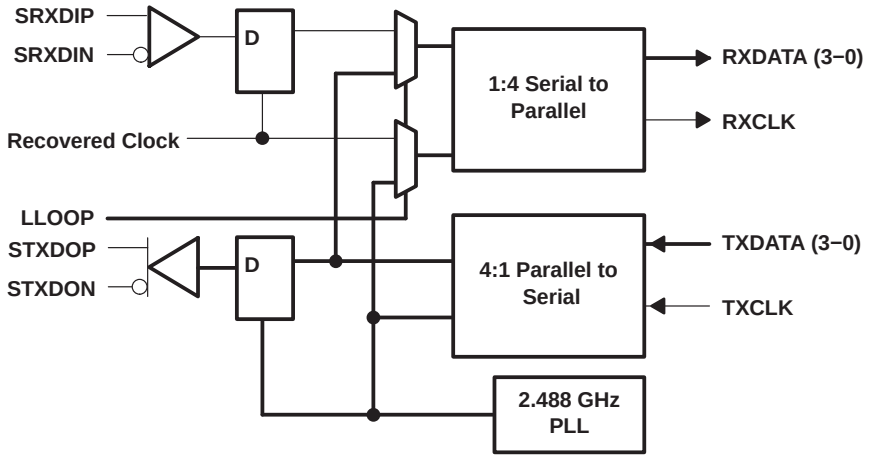


Figure 3. Local Loopback Data Path

remote loopback

The RLOOP signal pin controls the remote loopback. When RLOOP is high, the serial receive data is selected and presented on the serial transmit data output pins. The serial received data is also demultiplexed and presented on the parallel receive data pins. The remote loop can be enabled only when the device is under transceiver mode. When the device is put under the repeater mode with RX_MONITOR high, it performs the same function as remote loopback.

detailed description (continued)

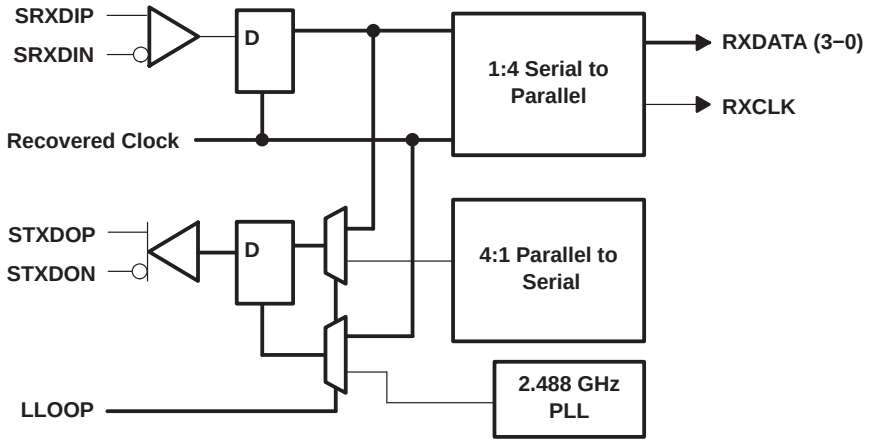


Figure 4. Remote Loopback Data Path/Repeater Mode Operation

PRBS

The SLK2721 device has two built-in pseudorandom bit stream (PRBS) functions. The PRBS generator is used to transmit a PRBS signal. The PRBS verifier is used to check and verify a received PRBS signal.

When the PRBSEN pin is high, the PRBS generator and verifier are both enabled. A PRBS is generated and fed into the parallel transmitter input bus. Data from the normal input source is ignored in PRBS mode. The PBRS pattern is then fed through the transmitter circuitry as if it was normal data and sent out by the transmitter. The output can be sent to a bit error rate tester (BERT) or to the receiver of another SLK2721 device. If an error occurs in the PRBS pattern, the PRBSPASS pin is set low for two RXCLKP/N cycles.

power-on reset

Upon application of minimum valid power, the SLK2721 device generates a power-on reset. During the power-on reset the PRXDATA[0:3] signal pins go to 3-state. RXCLKP and RXCLKN are held low. The length of the power-on reset cycle is dependent upon the REFCLKP and REFCLKN frequency but is less than 1 ms in duration.

absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage, V_{DD} . . . . . −0.3 to 3 V
Voltage range: TTL input terminals . . . . . −0.3 to 4 V
LVDS terminals . . . . . −0.3 to 3 V
Any other terminal except above . . . . . −0.3 to V_{DD} + 0.3 V
Package power dissipation, P_D . . . . . See Dissipation Rating Table
Storage temperature, T_{stg} . . . . . −65°C to 150°C
Electrostatic discharge . . . . . HBM: 2 kv
Characterized free-air operating temperature range, T_A . . . . . −40°C to 85°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds . . . . . 260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	$T_A \le 25°C$ POWER RATING	DERATING FACTOR§ ABOVE $T_A = 25°C$	$T_A = 85°C$ POWER RATING
PZP‡	3.4 W	33.78 mW/°C	1.3 W
PZP¶	2.27 W	22.78 mW/°C	0.911 W

‡ 2 oz trace and copper pad with solder.
§ This is the inverse of the traditional junction-to-ambient thermal resistance ($R_{\theta JA}$).
¶ 2 oz trace and copper pad without solder.

recommended operating conditions

PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
Supply voltage, V_{DD}		2.375	2.5	2.625	V
Power dissipation, P_D	Frequency = 2.488 Gb/sec, PRBS pattern		700	873	mW
Shutdown current	Enable = 0, V_{DDA}, V_{DD} pins, V_{DD} = max		20		µA
Operating free-air temperature, T_A		−40		85	°C

start up sequence

To ensure proper start up, follow one of the following steps when powering up the SLK2721 device.

1. Keep ENABLE (pin 44) low until power supplies and reference clock have become stable.
2. Drive ENABLE (pin 44) low for at least 30 ns after power supplies and reference clock have become stable.

electrical characteristics over recommended operating conditions (unless otherwise noted)

TTL

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{IH}	High-level input voltage		2		3.6	V
V_{IL}	Low-level input voltage				0.80	V
I_{IH}	Input high current	V_{DD} = MAX, V_{IN} = 2 V			40	μA
I_{IL}	Input low current	V_{DD} = MAX, V_{IN} = 4 V	−40			μA
V_{OH}	High-level output voltage	I_{OH} = −1 mA	2.10	2.3		V
V_{OL}	Low-level output voltage	I_{OH} = 1 mA		0.25	0.5	V
C_I	Input capacitance				4	pF

LVDS input signals

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_I	Input voltage		825		1575	mV
$V_{ID(th)}$	Input differential threshold voltage		100			mV
C_I	Input capacitance				3	pF
R_I	Input differential impedance	On-chip termination	80	100	120	Ω
t_{su}	Input setup time requirement	See Figure 7	300			ps
t_h	Input hold time requirement	See Figure 7	300			ps
$T_{(duty)}$	Input clock duty cycle		40%		60%	

LVDS output signals

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OD}	Output differential voltage	R_L = 100 ±1%	300		800	mV
V_{OS}	Output common mode voltage		1070		1375	
ΔV_{OD}	Change V_{OD} between 1 and 0				25	
ΔV_{OS}	Change V_{OS} between 1 and 0				25	
$I_{(SP)}$, $I_{(SN)}$, $I_{(SPN)}$	Output short circuit current	Outputs shorted to ground or shorted together			24	mA
I_{off}	Power-off current	V_{DD} = 0 V			10	μA
$t_{(cq_min)}$	Clock-output time	See Figure 6			100	ps
$t_{(cq_max)}$					100	
t_r/t_f	Output transition time	20% to 80%	100		300	ps
	Output clock duty cycle		45%		55%	
	Data output to FRAME_SYNC delay		4		7	Bit times

timing requirements over recommended operating conditions (unless otherwise noted)

reference clock (REFCLK)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Frequency tolerance†		−20		20	ppm
Duty cycle		40%	50%	60%	
Jitter	12 kHz to 20 MHz			3	ps rms
Frequency range absolute value			622.08		MHz

† The ±20-ppm tolerance is required to meet SONET/SDH requirements. For non-SONET/SDH-compliant systems, looser tolerances may apply.

PLL performance specifications

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
PLL startup lock time	V_{DD}, V_{DDC} = 2.375 V, after REFCLK is stable			1	ms
Acquisition lock time	Valid SONET signal or PRBS OC-48		2031		Bit Times

serial transmitter/receiver characteristics

PARAMETER		TEST CONDITIONS	MIN	NOM	MAX	UNIT
	Vodd = |STXDOP−STXDON|, transmit differential output voltage under de-emphasis	PRE1 = 0, PRE2 = 0, Rt = 50, See Table 4 and Figure 1	650	850	1000	mV
		PRE1 = 1, PRE2 = 0	550	750	900	mV
		PRE1 = 0, PRE2 = 1	540	700	860	
		PRE1 = 1, PRE2 = 1	500	650	800	
$V_{(CMT)}$	Transmit common mode voltage range	Rt = 50 Ω	1100	1250	1400	mV
	Receiver Input voltage requirement, Vid = |SRXDIP−SRXDIN|		150			mV
$V_{(CMR)}$	Receiver common mode voltage range		1100	1250	2250	mV
I_I	Receiver input leakage		−550		550	µA
R_I	Receiver differential impedance		80	100	120	Ω
C_I	Receiver input capacitance				1	pF
$t_{d(TX_Latency)}$					50	Bit Times
$t_{d(RX_Latency)}$					50	

serial differential switching characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_t	Differential signal rise time (20% to 80%)	R_L = 50 Ω,		80	100	140	ps
t_j	Output jitter	Jitter-free data,	12 kHz to 20 MHz, RLOOP = 1		0.05	0.1	$UI_{(pp)}$
	Jitter tolerance	RLOOP = 1 See Figure 3	1 MHz	0.15	0.4		$UI_{(pp)}$
			100 kHz	1.5	4		
			1 kHz	1.5	9		

TYPICAL CHARACTERISTICS

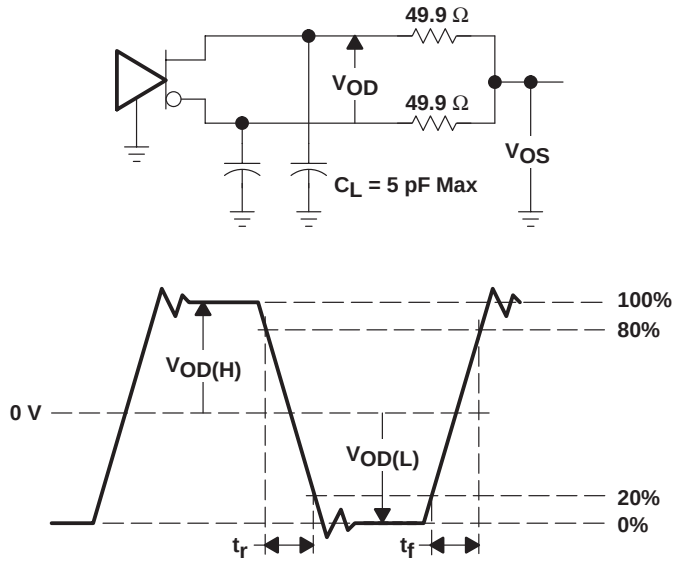


Figure 5. Test Load and Voltage Definitions for LVDS Outputs

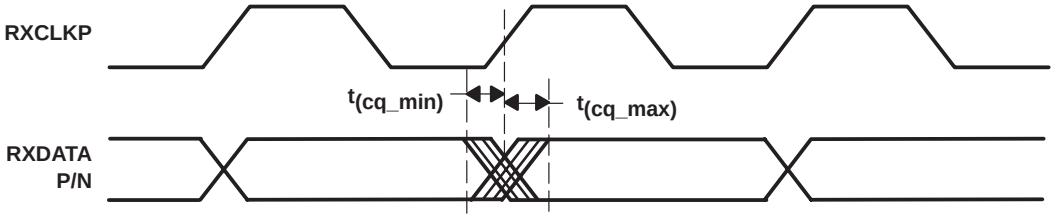


Figure 6. LVDS Output Waveform

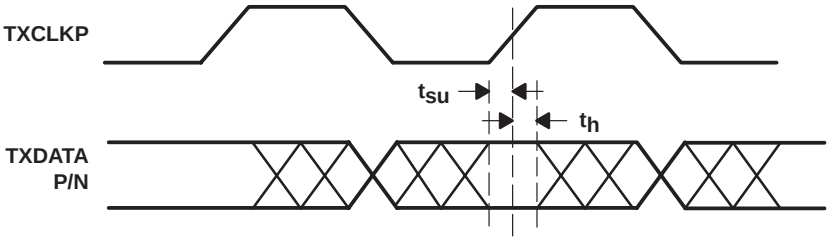


Figure 7. LVDS Input Waveform

APPLICATION INFORMATION

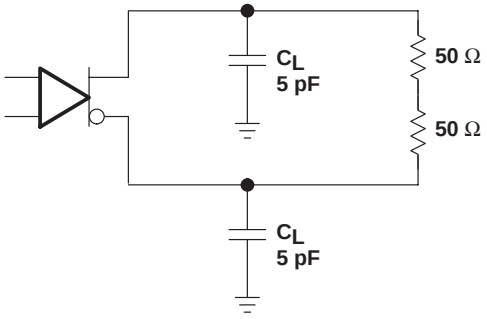


Figure 8. Transmitter Test Setup

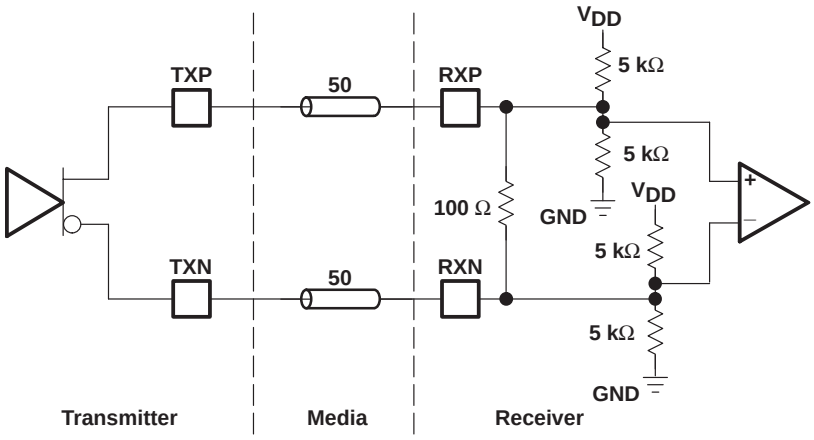


Figure 9. High-Speed I/O Directly-Coupled Mode

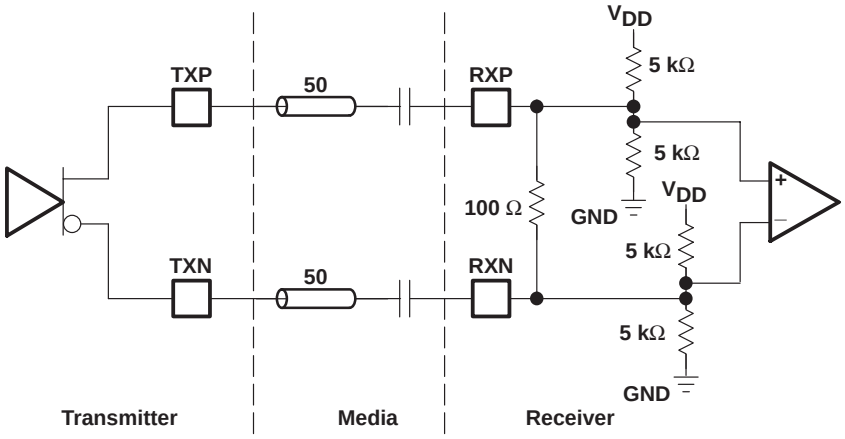


Figure 10. High-Speed I/O AC-Coupled Mode

APPLICATION INFORMATION

designing with the PowerPad package

The SLK2721 device is housed in high-performance, thermally enhanced, 100-pin PZP PowerPAD packages. Use of a PowerPAD package does not require any special considerations except to note that the PowerPAD, which is an exposed die pad on the bottom of the device, is a metallic thermal and electrical conductor. Correct device operation requires that the PowerPAD be soldered to the thermal land. Do not run any etches or signal vias under the device, but have only a grounded thermal land, as explained below. Although the actual size of the exposed die pad may vary, the minimum size required for the keepout area for the 100-pin PZP PowerPAD package is 12 mm $\times$ 12 mm.

A thermal land, which is an area of solder-tinned-copper, is required underneath the PowerPAD package. The thermal land varies in size depending on the PowerPAD package being used, the PCB construction, and the amount of heat that needs to be removed. In addition, the thermal land may or may not contain numerous thermal vias, depending on PCB construction.

Other requirements for thermal lands and thermal vias are detailed in the TI application note *PowerPAD™ Thermally Enhanced Package* Application Report, TI literature number SLMA002, available via the TI Web pages beginning at URL http://www.ti.com.

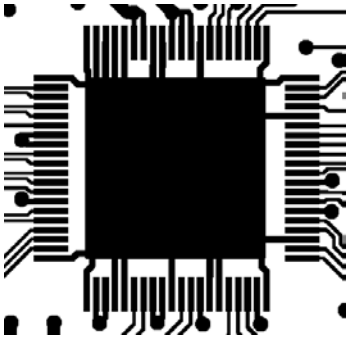


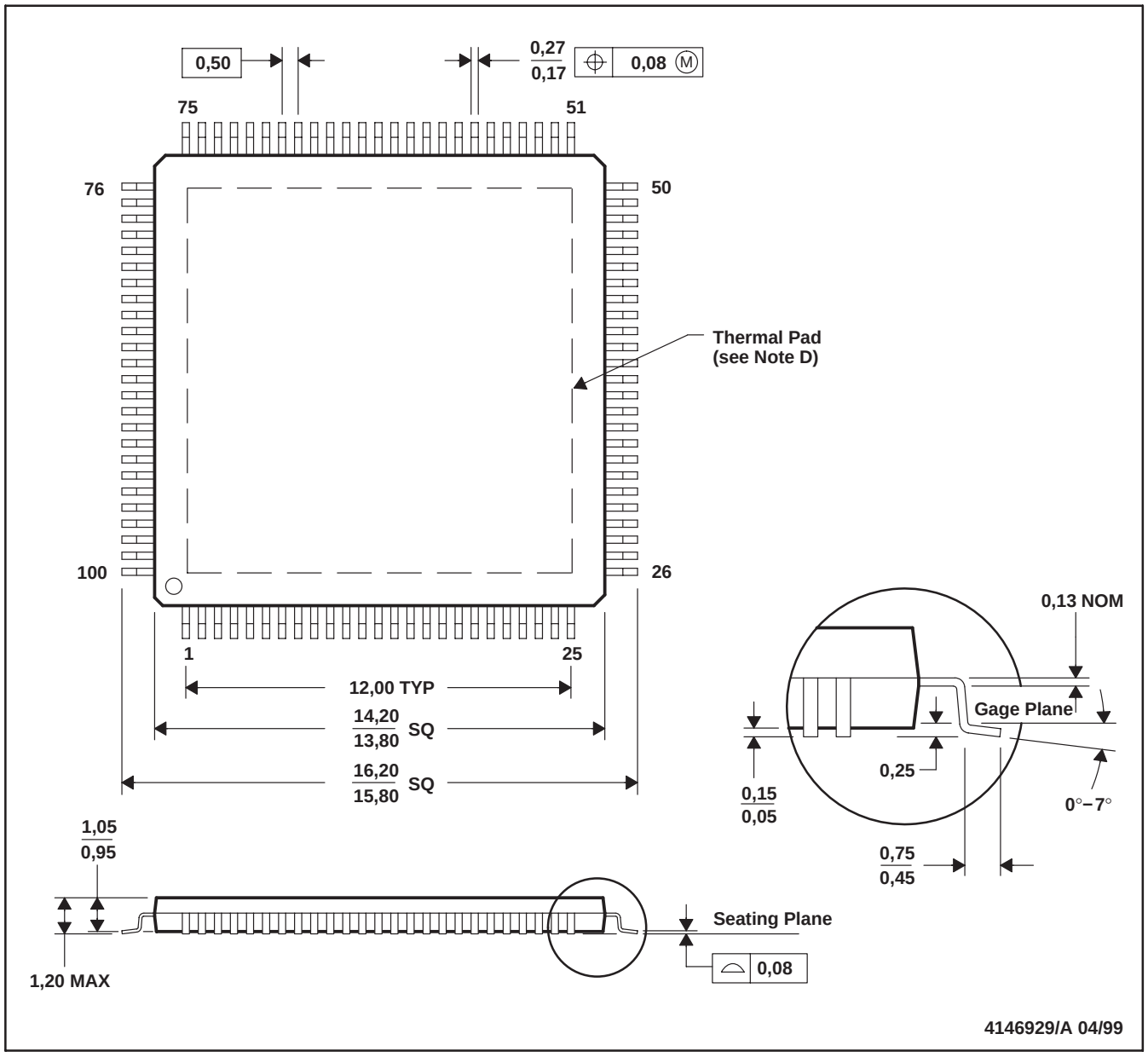
Figure 11. Example of a Thermal Land

For the SLK2721 device, this thermal land must be grounded to the low-impedance ground plane of the device. This improves not only thermal performance but also the electrical grounding of the device. It is also recommended that the device ground terminal landing pads be connected directly to the grounded thermal land. The land size must be as large as possible without shorting device signal terminals. The thermal land may be soldered to the exposed PowerPAD using standard reflow soldering techniques.

While the thermal land may be electrically floated and configured to remove heat to an external heat sink, it is recommended that the thermal land be connected to the low-impedance ground plane of the device. More information may be obtained from the TI application note *PHY Layout*, TI literature number SLLA020.

MECHANICAL DATA

PZP (S-PQFP-G100) **PowerPAD™ PLASTIC QUAD FLATPACK**



NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion.
D. The package thermal performance may be enhanced by bonding the thermal pad to an external thermal plane. This pad is electrically and thermally connected to the backside of the die and possibly selected leads.
E. Falls within JEDEC MS-026

For the latest package information, go to http://www.ti.com/sc/docs/package/pkg_info.htm
PowerPAD is a trademark of Texas Instruments.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)
SLK2721IPZP	ACTIVE	HTQFP	PZP	100	90	None	CU NIPDAU	Level-3-220C-168 HR

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
None: Not yet available Lead (Pb-Free).
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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